

Application/Control No.	Applicant(s)/Pate Reexamination	ent under
10/720,110	NAKAMURA, TA	AKAYUKI
Examiner	Art Unit	
ALEX LIEW	2624	

	SEARCHED				
Class	Subclass	Date	Examiner		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
Interferen	Interference search	3/5/2008	AL	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
382/141-152 crossed reference with 382/154	4/26/2007	AL		
382/106, 141-154 limited to text search	4/26/2007	AL		
Google patent search	4/28/2007	AL		
382/141-152 crossed reference with 382/154	10/7/2007	AL		
382/106, 141-154 limited to text search	10/7/2007	AL		
382/106, 141-154 limited to text search	3/5/2008	AL		
Inventor name seach	3/5/2008	AL		